Applicant(s)/Patent Under Application/Control No. Reexamination 10/798,957 FORSTER ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2821 Hoang V. Nguyen **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY 04-2004 Endo et al. 343/895 US-2004/0075616 A1 Α US-6,830,193 B2 12-2004 Tanaka, Masahiko 235/492 В С US-D US-Ε US-US-F

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р	-				
	Q					
	R	2				
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

US-

US-

US-

US-

US-US-

G

Н

J

Κ